

<b>Notice of References Cited</b>	Application/Control No. 09/886,191	Applicant(s)/Patent Under Reexamination CRADDOCK ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0061296 A1	03-2003	Craddock et al.	709/212
	B	US-2003/0050990 A1	03-2003	Craddock et al.	709/212
	C	US-6,594,712 B1	07-2003	Petty et al.	710/22
	D	US-6,813,653 B2	11-2004	Avery, James M.	710/22
	E	US-6,829,652 B1	12-2004	Wunderlich, Mark W.	709/245
	F	US-6,804,673 B2	10-2004	Sugahara et al.	707/10
	G	US-6,658,521 B1	12-2003	Biran et al.	710/315
	H	US-6,658,469 B1	12-2003	Massa et al.	709/224
	I	US-6,460,080 B1	10-2002	Shah et al.	709/224
	J	US-5,991,797 A	11-1999	Futral et al.	709/216
	K	US-6,851,059 B1	02-2005	Pfister et al.	713/200
	L	US-6,578,122 B2	06-2003	Beukema et al.	711/163
	M	US-2002/0073257 A1	06-2002	Beukema et al.	710/105

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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